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# Design Methodology of Current Buffer based Two Stage CMOS Op-Amp with Compensation Strategy

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#### Abstract

High Bandwidth Operational Amplifiers are needed for many applications. The Design methodology with current buffer overcomes the drawbacks in design strategies of nulling resistor and voltage buffer. The approach here provides improved gain bandwidth product and a gain of 42 dB on 0.5µm technology when operated on a supply voltage of 2.5 volts.

**Keywords**—CMOS analog integrated circuits, Current Buffer, Common Source Stage, Compensation Capacitor, Op-Amp.

#### Introduction

Operational amplifiers are amplifiers (controlled sources) that have sufficiently high forward gain so that when negative feedback is applied, the closed-loop transfer function is practically independent of the gain of the op-amp. Most of the amplifiers do not have a large enough gain. Consequently, most CMOS op-amps use two or more gain stages [1]-[3].

The goal of compensation is to maintain stability when negative feedback is applied around the op-amp.

## I. OP-AMP GAIN

Figure below shows block diagram of a two stage op-amp.



Fig 1 A Two stage Op-amp block Diagram.

First stage differential-to-single ended gain is given by

 $A_{v1} = g_{m1}(r_{ds2} \parallel r_{ds4})$ 

where

Second stage gain is given by

$$A_{v2} = -g_{m7}(r_{ds6} \parallel r_{ds7})$$
 (2)

Third stage is a source-follower and is only included if resistive loads need to be driven. If the load is purely capacitive in the case of integrated op-amps this stage is seldom included

$$A_{v3} \cong \frac{g_{ms}}{G_L + g_{ms} + g_{dss} + g_{dss}}$$
(3)

Where  $G_L$  is the load conductance being driven by the buffer stage.



Fig 2 A Two stage Op-amp with second common source stage.

## **II. COMPENSATION PROCEDURE**

Compensation procedure followed is:

- a) Start by choosing  $C_c=5pF$  arbitrarily.
- b) Using SPICE find the frequency where there is a  $125^{\circ}$  phase shift. Let the gain at this frequency be denoted A'. Also let the frequency be denoted  $\omega_t$ . This is the frequency that we would like to become the unity-gain frequency of the loop gain[3].
- c) Choose a new  $C_c$  so that  $\omega_t$  becomes the unity-gain Frequency of the loop-gain, thus resulting in a 55° phasemargin (and the reason for the choice of 125° used above). This can be achieved by taking  $C_c$  according to the equation.  $C_c = Cc' A'$  (4)

 $C_c = Cc A$  (4) It might be necessary to iterate on  $C_c$  a couple of times using SPICE.

d) Choose  $R_C$  according to

(1)

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$$R_c = \frac{1}{1.2 \omega_t}$$

This choice will increase the unity-gain frequency by about 20%, leaving the zero near to the final resulting unity-gain frequency, which will end up about 15% below the equivalent second pole frequency. The resulting phase margin is approximately  $-85^{\circ}$ . This allows a margin of  $5^{\circ}$  to account for processing variations without the poles of the closed-loop response becoming real. This choice is also near optimum lead-compensation for almost any Opamp when a resistor is placed in series with the compensation capacitor. It might be necessary to iterate on a couple of times to optimize the phase-margin. However, it should be checked that the gain continues to steadily decrease at frequencies above the new unity-gain frequency, otherwise the transient response can be poor. This situation sometimes occurs when unexpected zeros at frequencies only slightly greater than are present[1]-[3].

e) If after d), the phase-margin is not adequate, then increase  $C_C$  while leaving  $R_C$  constant. This will move both  $\omega_t$  and the leadzero to lower frequencies, while keeping their ratio approximately constant, thus minimizing the effects of higher frequency poles and zeros which, hopefully, do not also move to lower frequencies.

In most cases, the higher-frequency poles and zeros (except for the lead zero) will not move to significantly-lower frequencies when increasing.



Fig. 3 Opamp with robust bias circuit

TABLE I							
Robust Bias Op Amp	Design	Procedure	[4]				

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Step 1	$C_{C} = \frac{16kT}{3\omega_{u}S_{n}(f)} \left[ 1 + \frac{SR}{\omega_{u}(V_{HR}^{CM+} + V_{In})} \right]$
Step 2	$I_{D7} = SR(C_C + C_L)$
Step 3	$L_6 = \sqrt{\frac{3\mu_p V_{HR}^{\text{out+}} C_C}{2\omega_u C_L \tan \phi_M}}$
Step 4	$W_{6} = \frac{2SR(C_{C} + C_{L})}{\mu_{p}C_{OX}(V_{HR}^{\text{out}+})^{2}}L_{6}$
Step 5	$I_{D5} = C_C SR$
Step 6	$\left(W/L\right)_{1,2} = \frac{\omega_u^2 C_C}{\mu_n C_{OX} SR}$
Step 7	$(W/L)_{5,8} = \frac{2SRC_C}{\mu_n C_{OX} (V_{HR}^{CM} - V_{in} - SR/\omega_u)^2}$
Step 8	$(W/L)_7 = \left(\frac{C_C + C_L}{C_C}\right)(W/L)_{5,8}$
Step 9	$(W/L)_{3,4} = \frac{(W/L)_6}{2(W/L)_7} (W/L)_{5,8}$
Step 10	$I_{D9} = \frac{(\tan \phi_M \omega_u C_L)^2 \left( C_C + \frac{2}{3} W_9 L_9 C_{OX} \right)^2}{2 \mu_n C_{OX} (W_0 / L_0)}$

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TABLE II Design Parameters For Robust Bias Op Amp

(W/L) <sub>1,2</sub>	.7μm/1μm
(W/L) <sub>3,4</sub>	1.8µm/1µm
(W/L) <sub>5,8</sub>	1.6µm/1µm
(W/L) <sub>6</sub>	38.6µm/1µm
(W/L) <sub>7</sub>	17µm/1µm
(W/L) <sub>9</sub>	27µm/1µm
(W/L) <sub>bl-</sub> b4	1.6µm/1µm
(W/L) <sub>b5</sub>	6.4µm/1µm
(W/L) <sub>b6</sub> . b7	131µ/1µm
(W/L) <sub>b8</sub>	27µm/1µm
(W/L) <sub>b9-</sub> b10	7.4µm/1µm
R <sub>b</sub>	32K
Cc	0.5pF

#### TABLE III Simulation Results

Sinulation Results								
Opamp	with	Common	Source	Opamp	with	Current		
Stage				Buffer				
GAIN in db								
		62			42			

# III. CONCLUSIONS

Compared to the procedure based upon the nullifying resistor compensation the value of  $C_C$  of the proposed procedure [4] can be made much smaller. The wider range of the allowable value of  $C_C$  provides a higher flexibility for noise-power tradeoff.

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